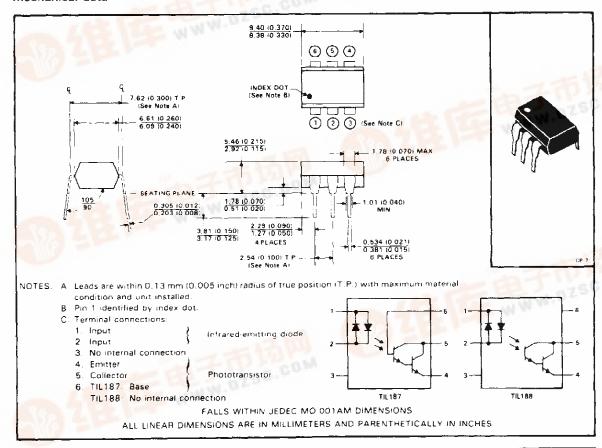
TIL187-1 THRU TIL187-4 TIL188-1 THRU TIL188-4 AC-INPUT OPTOCOUPLERS/OPTOISOLATORS SOOS012A D2980, JANUARY 1987-REVISED JULY 1989

- AC Signal Input
- Gallium Arsenide Dual-Diode Infrared Source Optically Coupled to a Silicon N-P-N Darlington Phototransistor
- Plastic Dual-In-Line Package
- High-Voltage Electrical Isolation, 3.535 kV
 Peak (2.5 kV rms)
- High Current Transfer Ratio, 500% Minimum at IF = 10 mA, Up to 1500% Minimum at IF = 2 mA with Four Categories
- High V(BR)CEO, 55 V Min
- UL Recognized File #E65085
- No Base Lead Connection on TIL188 for High-EMI Environment

description

The TIL187 and TIL188 Optocouplers are designed for use in AC applications that require very high current transfer ratio and high voltage isolation between input and output. These optocouplers consist of two GaAs light-emitting diodes connected in a reverse-parallel configuration and a silicon n-p-n Darlington phototransistor. The TIL187 has the base connected for applications where a base signal or base resistor is required. The TIL188 is designed with no base connected for applications where high base-noise immunity is desired. Users can select from four different current gains (TIL187-1 through TIL188-4).

mechanical data



PRODUCTION DATA documents contain information current as of publication date. Products conferm to specifications per the terms of Texas Instruments standerd warranty. Production processing does not necessarily include testing of all parameters.



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TIL187-1 THRU TIL187-4 TIL188-1 THRU TIL188-4 AC INPUT OPTOCOUPLERS/OPTOISOLATORS

absolute maximum ratings at 25 °C free-air temperature (unless otherwise noted) Input diode continuous forward current at (or below) Continuous power dissipation at (or below) 25 °C free-air temperature: Total, infrared-emitting diode plus phototransistor (see Note 4) 250 mW NOTES: 1. This value applies when the base-emitter diode is open circuited. 2. Derate linearly to 100 °C free-air temperature at the rate of 1.33 mA/°C.

- - 3. Derate linearly to 100°C free-air temperature at the rate of 2 mW/°C
 - 4. Denate linearly to 100°C free-air temperature at the rate of 3.33 mW/°C

electrical characteristics at 25 °C free-air temperature (unless otherwise noted)

		TEST CONDITIONS	TIL187			TIL188			
	PARAMETER		MIN	TYP	MAX	MIN	TYP	MAX	UNIT
V(BR)CBO	Collector-base breakdown voltage	$I_{C} = 10 \mu\text{A}, I_{E} = 0,$ $I_{F} = 0$	100						V
V(BR)CEO	Collector-emitter breakdown voltage	I _C - 1 mA, I _B - 0, I _F = 0	55			55			٧
V(BR)EBO	Emitter-base breakdown voltage	$I_E = 10 \mu A$, $I_C = 0$, $I_F = 0$	14						٧
V(BRIECO	Emitter-collector breakdown voltage	I _E = 10 μΑ, I _F = 0				7			>
On-s IC(on) colle curr	TIL187-1, TIL188-1	V _{CE} = 1 V, I _F = 2 mA, I _B = 0	5			5			mA
	Photo- TIL187-2, TIL188-2		10			10		_	
	TIL187 3, TIL188 3		20			20			
	I ITII 187 4 TII 188 4		30			30			, , , ,
	1	V _{CE} = 1 V, I _F = 10 mA, I _B = 0	50			50			
	Photodiode operation	V _{CB} = 1 V, I _F = 10 mA, I _E = 0		12					μΑ
IC(off)	Off-state collector current	V _{CE} = 10 V, I _F = 0.			100		_	100	пA
hFE	Transistor static forward current transfer ratio	V _{CE} = 1 V, I _C = 10 mA, I _F = 0		25000	-				
∨ _F †	Input diode static forward voltage	lp = 10 mA	1	1.2	1.5	1	1.2	1.5	V
VCE(sat)	Collector-emitter saturation voltage	$I_C = 50 \text{ mA}, I_F = 10 \text{ mA},$ $I_B = 0$		0.87	1		0.87	1	٧
rio	Input-to-output internal resistance	V _{in-out} = ±500 V, See Note 5	1011			1011			Ω
Cio	Input-to-output capacitance	$V_{in-out} = 0$, $f = 1$ mHz, See Note 5		1	1.3		1	1.3	pF
I _{C(on)1} I _{C(on)2}	On-state collector current symmetry ratio (see Note 6)	V _{CE} = 1 V, I _F = 2 mA	1		3	1		3	

[†]These parameters apply for either direction of the input current.

NOTES: 5. These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together.

switching characteristics at 25 °C free-air temperature

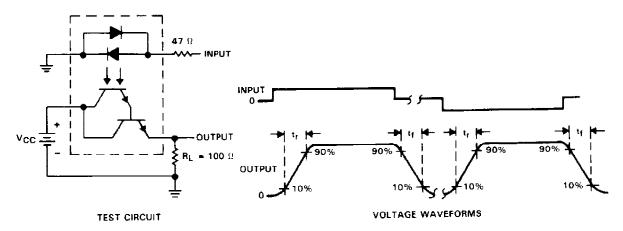
PARAMETER	TEST CONDITIONS			TIL187			TIL188		
PANAMETER			MIN	TYP	MAX	MIN	TYP	MAX	UNIT
t _f Rise time	V _{CC} = 10 V.	I _{Cloni} = 10 mA,		100			100		μS
t _f Fall time	R _L - 100 Ω,	see Figure 1		100			100		μS

^{6.} The higher of the two $I_{C(on)}$ values generated by the two diodes is taken as $I_{C(on)1}$.

AC-INPUT OPTOCOUPLERS/OPTOISOLATORS

PARAMETER MEASUREMENT INFORMATION

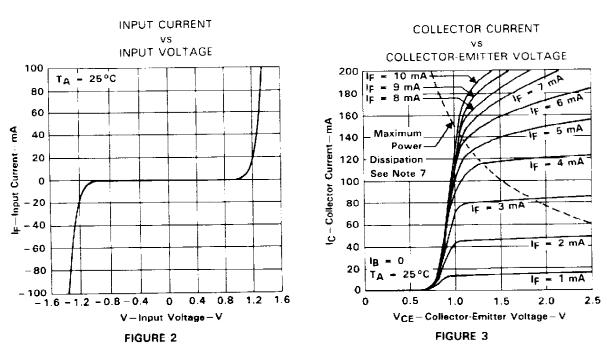
Adjust amplitude of input pulse is for IC(on) = 10 mA



NOTES: A The input waveform is supplied by a generator with the following characteristics: $Z_0 = 50 \,\Omega$, $t_r = \pm .15$ ns. duty cycle = 1%. B. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \le .12$ ns. $R_1 \ge .1$ M Ω , $C_n \le .20$ pF.

FIGURE 1. SWITCHING TIMES

TYPICAL CHARACTERISTICS

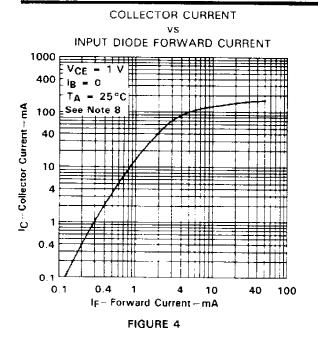


Note 7: Pulse operation is required for operation beyond limits shown by the dashed line



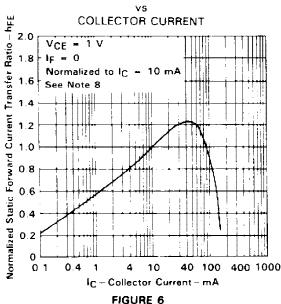
TIL187-1 THRU TIL187-4 TIL188-1 THRU TIL188-4 AC-INPUT OPTOCOUPLERS/OPTOISOLATORS

NORMALIZED ON STATE COLLECTOR CURRENT



VS FREE-AIR TEMPERATURE 1.2 VCE = 1 V IF = 10 mA $l_B = 0$ Normalized Collector Current—IC(on) 1.0 IF - 2 mA 0.8 0.4 0.2 0 - 50

TIL 187 NORMALIZED TRANSISTOR STATIC FORWARD CURRENT TRANSFER RATIO



TIL187 NORMALIZED TRANSISTOR STATIC FORWARD CURRENT TRANSFER RATIO

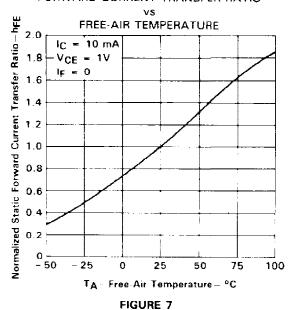
TA-Free-Air Temperature- °C

FIGURE 5

75

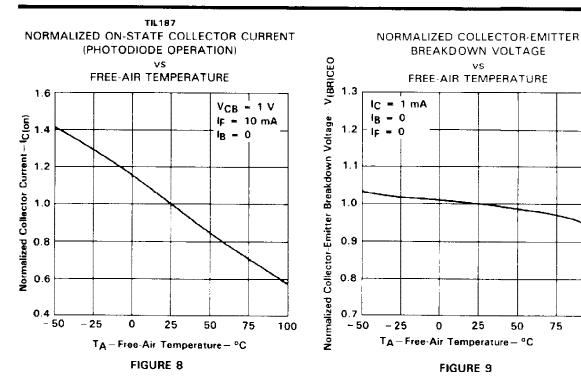
100

- 25

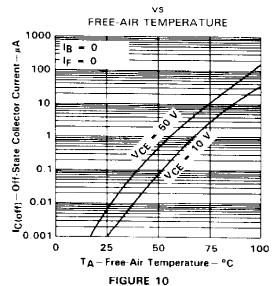


NOTE 8: These parameters were measured using pulse techniques $t_{W}=1$ ms, duty cycle $\leq 2\%$.

TIL187-1 THRU TIL187-4 TIL188-1 THRU TIL188-4 AC-INPUT OPTOCOUPLERS/OPTOISOLATORS



OFF-STATE COLLECTOR CURRENT



75

100

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